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# **RADIO TEST REPORT**

Test Report No.: 30EE0055-HO-01-B

Applicant : Sand Dollar Enterprise, Inc.

Type of Equipment : Computer Entertainment System

Model No. : CECH-2101A

FCC ID : XCET12NA28K

Test regulation : FCC Part 15 Subpart C 2009

Section 15.207, Section 15.247

\*Conducted Emission, Maximum Peak Output Power, and Spurious Emission (Radiated) tests for

**Class II Permissive Change** 

Test Result : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.

- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with the above regulation.
- 4. The test results in this report are traceable to the national or international standards.
- 5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Date of test:

December 9, 2009 to January 15, 2010

Tested by:

Takeshi Choda EMC Services

Approved by:

Mitsuru Fujimura Site Manager of EMC Services



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.

\*As for the range of Accreditation in NVLAP, you may refer to the WEB address, http://uljapan.co.jp/emc/nvlap.html

Takumi Shimada

**EMC Services** 

UL Japan, Inc.

**Head Office EMC Lab.** 

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### **SECTION 1: Customer information**

Company Name	Sand Dollar Enterprise, Inc.
Address	919 East Hillsdale Boulevard, Foster City, CA 94404
Telephone Number	1-650-655-8040
Contact Person	Riley Russell

### **SECTION 2: Equipment under test (E.U.T.)**

#### 2.1 Identification of E.U.T.

Type of Equipment	Computer Entertainment System
Model No	CECH-2101A
Serial No	1000194 (Power Supply: SONY)
	1000196 (Power Supply: DELTA)
	1000202 Used for Antenna Terminal Conducted tests
Rating	AC120V / 60Hz
Country of Manufacture	JAPAN/CHINA
Receipt Date of Sample	December 7, 2009
Condition of EUT	Production prototype
	(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	No modification by the test lab.

#### 2.2 Product Description

Model: CECH-2101A, referred to as the EUT in this report, is a Computer Entertainment System.

The EUT contains Bluetooth (Ver. 2.0+EDR) module and IEEE802.11b/g WLAN module. Those modules do not transmit simultaneously.

Series model: CECH-2102B

Difference between the original model: CECH-2101A and CECH-2102B is HDD type only.

#### Factory:

- 1. Sony EMCS Corporation Kisarazu Tec
- 8-4 Shiomi Kisarazu-shi Chiba-ken, 202-0834 Japan
- 2. Maintek Computer (Suzhou) Co., Ltd.

Bldg. 2, 233 Jin Feng Rd Suzhou Jiangsu China

- 3. Hongfujin Precision Electrons (Yantai) Co., Ltd.
- B Sec Export Processing Zone, 50 Beijing Zhong RD,

Yantai Economic & Technological Development Area, Yantai Shandong China

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The clock frequencies used in the EUT: Max clock frequency is 3.2GHz.

### Bluetooth (Ver. 2.0+EDR)

Equipment Type	Transceiver
Frequency of Operation	2402-2480MHz
Type of Modulation	FHSS (GFSK, π/4-DQPSK, 8DPSK)
Bandwidth & Channel spacing	1MHz & 1MHz
Power Supply (inner)	DC5.0V
Antenna Type	PIFA
Antenna Gain	2.5 dBi (max)
Antenna Connector Type	U.FL

#### IEEE802.11b/g WLAN

Equipment Type	Transceiver	
Frequency of Operation	2412-2462MHz	
Type of Modulation	DSSS/OFDM	
Bandwidth & Channel spacing	20MHz & 5MHz	
Power Supply (inner)	DC5.0V	
Antenna Type	ANT 0: IFA	ANT 1: PIFA
Antenna Gain	ANT 0: 4.3 dBi (max)	ANT 1: 2.5 dBi (max)
Antenna Connector Type	ANT 0: N/A	ANT 1: U.FL

For IEEE802.11b/g WLAN part, please see UL Japan, Inc. Test Report Number: 30EE0055-HO-01-A.

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### **SECTION 3: Test specification, procedures & results**

### 3.1 Test Specification

Test Specification : FCC Part15 Subpart C: 2009, final revised on February 27, 2009

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional

Radiators

Section 15.207 Conducted limits

Section 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz, and 5725-5850MHz

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<sup>\*</sup>Conducted Emission, Maximum Peak Output Power, and Spurious Emission (Radiated) tests were only performed for Class II Permissive Change

<sup>\*</sup>The EUT complies with FCC Part 15 Subpart B: 2009, final revised on December 2, 2009. Please refer to UL Japan, Inc., Test Report No.: 30EE0100-YW.

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#### 3.2 Procedures and results

Item	Test Procedure	Specification	Worst Margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.2	FCC: Section 15.207 IC: RSS-Gen 7.2.2	Tx  QP 5.2dB, 0.15000MHz, L DH5 2402MHz & 3DH5 2480MHz AV 9.3dB, 0.38658MHz, N DH5 2402MHz & 3DH5 2480MHz  Rx  QP 5.2dB, 0.15000MHz, L AV	Complied	-
Carrier Frequency Separation	FCC: FCC Public Notice DA 00-705	FCC: Section15.247(a)(1) IC: RSS-210 A8.1 (b)	9.3dB, 0.38656MHz, N N/A	N/A*1)	-
20dB Bandwidth	FCC: FCC Public Notice DA 00-705	FCC: Section15.247(a)(1) IC: RSS-210 A8.1 (a)	N/A	N/A	-
Number of Hopping Frequency	FCC: FCC Public Notice DA 00-705	FCC: Section15.247(a)(1)(iii) IC: RSS-210 A8.1 (d)	.N/A	N/A*1)	-
Dwell time	FCC: FCC Public Notice DA 00-705	FCC: Section15.247(a)(1)(iii) IC: RSS-210 A8.1 (d)	.N/A	N/A*1)	-
Maximum Peak Output Power	FCC: FCC Public Notice DA 00-705 IC: RSS-Gen 4.8	FCC: Section15.247(b)(1) IC: RSS-210 A8.4 (2)	.See data.	Complied	Conducted
Spurious Emission & Band Edge Compliance	FCC: FCC Public Notice DA 00-705 IC: RSS-Gen 4.9 RSS-Gen 4.10	FCC: Section15.247(d)  IC: RSS-210 A8.5	[Tx] 5.3dB 749.992MHz, QP, Vert., DH5 2402MHz 215.999MHz, QP, Hori, DH5/3DH5 2441MHz & 3DH5 2480MHz [Rx] 5.0dB, 215.999MHz, QP, Hori	Complied	Radiated Conducted* *1)

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

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<sup>\*1)</sup> The test was not performed, because this report is for Class II Permissive change and the tests was not required.

<sup>\*</sup> In case any questions arise about test procedure, ANSI C63.4: 2003 is also referred.

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#### FCC 15.31 (e)

This EUT provides stable voltage(DC5.0V) constantly to RF part regardless of input voltage. Therefore, this EUT complies with the requirement.

#### FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

#### 3.3 Addition to standard

Other than above, no addition, exclusion nor deviation has been made from the standard.

#### 3.4 Uncertainty

#### **EMI**

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room	Conducted emission
(semi-	( <u>+</u> dB)
anechoic	150kHz-30MHz
chamber)	
No.1	3.7dB
No.2	3.7dB
No.3	3.7dB
No.4	3.7dB

Test room		diated emiss	-			Radiated			
(semi-	(	(10m*)( <u>+</u> dB	)			(3m*)(	<u>+</u> dB)		
anechoic	9kHz-	30MHz-	300MHz-	9kHz-	30MHz-	300MHz-	1GHz-	18GHz-	26.5GHz-
chamber)	30MHz	300MHz	1GHz	30MHz	300MHz	1GHz	18GHz	26.5GHz	40GHz
No.1	3.1dB	4.4dB	3.9dB	3.2dB	3.8dB	3.9dB	5.0dB	5.0dB	5.4dB
No.2	-	-	-	3.2dB	4.4dB	4.0dB	5.0dB	5.2dB	5.4dB
No.3	-	-	-	3.2dB	4.2dB	3.8dB	5.0dB	5.3dB	5.3dB
No.4	-	-	-	3.2dB	4.0dB	3.8dB	5.0dB	5.3dB	5.3dB

<sup>\*10</sup>m/3m = Measurement distance

Power meter ( <u>+</u> dB)				
Below 1GHz	Above 1GHz			
1.0dB	1.0dB			

Antenna terminal conducted emission					Channel power
	Power density (-		( <u>+</u> dB)		( <u>+</u> dB)
Below 1GHz	1GHz-3GHz	3GHz-18GHz	18GHz-26.5GHz 26.5GHz-40GHz		
1.0dB	1.1dB	2.7dB	3.2dB	3.3dB	1.5dB

#### Conducted Emission test

The data listed in this test report has enough margin, more than the site margin.

### Radiated emission test(3m and/or 10m)

The data listed in this test report has enough margin, more than the site margin.

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#### 3.5 Test Location

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Telephone: +81 596 24 8116 Facsimile: +81 596 24 8124

	FCC	IC Registration	Width x Depth x	Size of	Other
	Registration Number	Number	Height (m)	reference ground plane (m) / horizontal conducting plane	rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

<sup>\*</sup> Size of vertical conducting plane (for Conducted Emission test): 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

#### 3.6 Test set up, Data of EMI, and Test instruments

Refer to APPENDIX.

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#### **SECTION 4: Operation of E.U.T. during testing**

#### 4.1 Operating Mode(s)

Test	Mode	Tested frequency
Conducted Emission*1)	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping OFF)	2402MHz(L)
	- DH5	2441MHz(M)
	- 3DH5	2480MHz(H)
	Bluetooth Receiving (Rx)	2441MHz(M)
Spurious Emission	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping OFF)	2402MHz(L)
(Radiated)	- DH5	2441MHz(M) *2)
	- 3DH5	2480MHz(H)
	Bluetooth Receiving (Rx)	2441MHz(M)
Maximum Peak Output	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping OFF)	2402MHz(L)
Power	- DH5	2441MHz(M)
	- 2DH5	2480MHz(H)
	- 3DH5	
	Inquiry	2441MHz(M)
Band Edge Compliance	Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping OFF)	2402MHz(L)
	- DH5	2480MHz(H)
	- 3DH5	

As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload (except Dwell time test). For EDR, test was performed with 3DH5 as a representative.

Remarks: Test was not performed at AFH mode, because the decrease of number of channel (min: 20ch) at AFH mode does not influence on the output power and bandwidth of the EUT.

However, the limit level 125mWof AFH mode was used due to the overlap of the bandwidth. . .

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<sup>\*</sup>Since there are two kinds of manufacture's antennas (TYCO and HITACHI), the test was performed with TYCO antenna according to the customer's request because they have identical antenna characteristics.

<sup>\*1)</sup> The test was performed for both of Power Supply: SONY and Power Supply: DELTA. Other tests besides Conducted Emission test were performed with Power Supply: SONY as a representative.

<sup>\*2)</sup> The difference of between Power Supply: SONY and Power Supply: DELTA was confirmed by Bluetooth Transmitting (Tx) Payload: PRBS9 (Hopping OFF) DH5 mode.

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### 4.2 Configuration and peripherals

This page has been submitted for a separate exhibit.

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### **SECTION 5: Conducted Emission**

#### **Test Procedure and conditions**

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane.

The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

#### 1) For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber or a Measurement Room.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector : QP and AV
Measurement range : 0.15-30MHz
Test data : APPENDIX
Test result : Pass

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#### **SECTION 6: Radiated Spurious Emission**

#### **Test Procedure**

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

The height of the measuring antenna varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

#### Test Antennas are used as below;

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

Frequency	Below 1GHz	Above 1GHz	Above 1GHz		
Instrument used	Test Receiver	Spectrum Analyzer	Spectrum Analyzer *1)		
Detector	QP	PK	AV		
IF Bandwidth	BW 120kHz(T/R)	RBW: 1MHz	RBW: 1MHz		
		VBW: 1MHz	VBW: 10Hz		
			VBW: 270Hz *2)		
Test Distance	3m	3m (below 10GHz)	3m (below 10GHz),		
		1m*3) (above 10G)	1m*3) (above 10GHz),		
		0.5m*4) (above 26.	0.5m*4) (above 26.5GHz)		

<sup>\*1)</sup> The Spectrum Analyzer was used in 3dB resolution bandwidth.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 30M-25GHz Test data : APPENDIX : Pass

Test result

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<sup>\*2)</sup> VBW was determined that it is calculation based on the frequency of the radio transmitted signal from EUT, since pulse emission and duty cycle was less than 100%.

<sup>\*3)</sup> Distance Factor:  $20 \times \log (3.0 \text{m}/1.0 \text{m}) = 9.5 \text{dB}$ 

<sup>\*4)</sup> Distance Factor:  $20 \times \log (3.0 \text{m}/0.5 \text{m}) = 15.6 \text{dB}$ 

<sup>-</sup> The carrier level and noise levels were confirmed at each position of X and Y axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

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## **SECTION 7: Antenna Terminal Conducted Tests**

#### **Test Procedure**

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
Maximum Peak	-	-	-	Auto	Peak	-	Power Meter
Output Power							(Sensor: 50MHz BW)

The test results and limit are rounded off to two decimals place, so some differences might be observed.

Test data : APPENDIX

Test result : Pass

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